Form PTO 144 (Modified)	•	U.S. DEPARTME PATENT AND T	NT OF COMMERCE RADEMARK OFFICE	ATTY DOCKET NO.			SERIAL NO. 10/687, 085		
				244081US2 APPLICANT			NEW APPLICATION		
LISTO	F REFE	ERENCES CITED BY	APPLICANT						
				Hiroshi MAEDA					
				HEREWITH 10-17-2003			2813		
<b>53/4444</b>				U.S. PATENT DO	CUMENTS				
EXAMINER INITIAL	<u> </u>	DOCUMENT NUMBER	DATE	NAME CLA		CLASS	SUB FILING DATE CLASS IF APPROPRIATE		ILING DATE
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		FOREIGN PATENT DOCUMENTS							
0110		DOCUMENT NUMBER	DATE		COUNTRY		TRANSLATION YES NO		LATION NO
45W/A3	AO	2000-357743	12/26/00	Japan (with Englis	h Abstract)				X
AlVidi	AP	2002-203866	07/19/02	Japan (with Englis	h Abstract)				x
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		OTHER R	EFERENCES (In	cluding Author,	litle, Date, Pertinen	t Pages, et	c.)		
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	AZ	A 1	0	Additi			ional References sheet(s) attached		
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Examiner: Iniconformance	tial life and not	ference is considered considered. Include c	whether or not o	itation is in confor	mance with MPEP 60	9; Draw line	through o	itation i	f not in
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